

Am79512/4

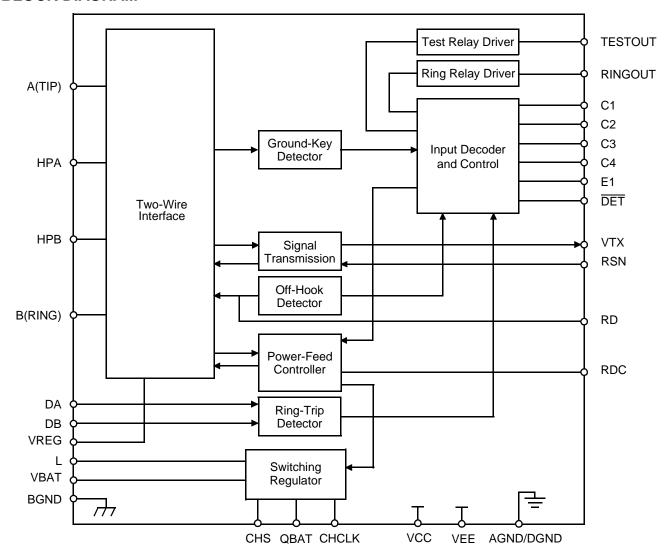
Subscriber Line Interface Circuit

DISTINCTIVE CHARACTERISTICS

- Programmable constant-current feed
- Programmable loop-detect threshold
- On-chip switching regulator for low-power dissipation
- Polarity reversal feature
- Optimized for –60 V battery

- Line feed characteristics independent of battery variations
- Two-wire impedance set by single external impedance
- Tip Open state for ground-start lines
- Ring and test relay drivers
- On-hook transmission

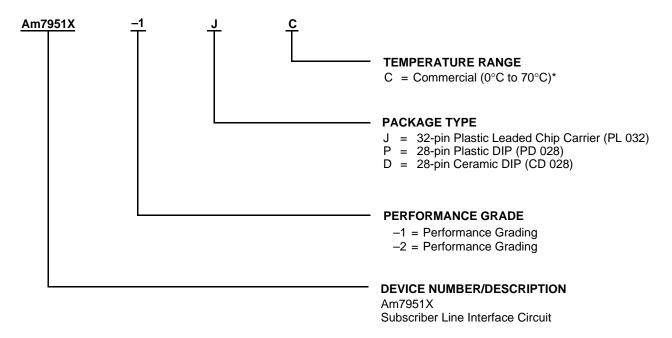
BLOCK DIAGRAM



ORDERING INFORMATION

Standard Products

AMD standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of the elements below.



Valid Combinations						
Am7951X	-1 -2	DC JC PC				

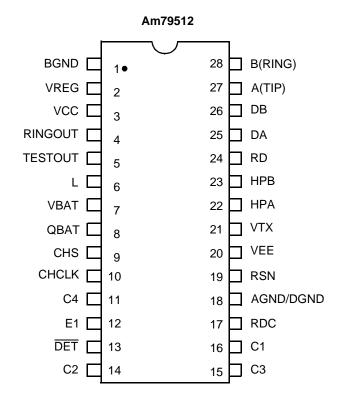
Valid Combinations

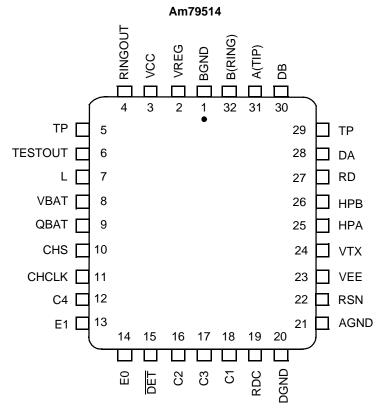
Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations, to check on newly released combinations, and to obtain additional data on AMD's standard military grade products.

Note:

^{*} Functionality of the device from 0° C to +70° C is guaranteed by production testing. Performance from -40° C to +85° C is guaranteed by characterization and periodic sampling of production units.

CONNECTION DIAGRAMS Top View





Notes:

- 1. Pin 1 is marked for orientation.
- 2. TP is a thermal conduction pin tied to substrate.

PIN DESCRIPTIONS

Pin Names	Туре	Description
AGND	Gnd	(Am79514) Analog ground
AGND/DGND	Gnd	(Am79512) Analog and Digital ground are connected internally to a single pin.
A(TIP)	Output	Output of A(TIP) power amplifier.
BGND	Gnd	Battery (power) ground.
B(RING)	Output	Output of B(RING) power amplifier.
C3-C1	Inputs	Decoder. C3 is MSB and C1 is LSB.
C4	Input	TTL compatible. A logic High enables the driver.
CHCLK	Input	Input to switching regulator (TTL compatible) Frequency = 256 kHz (nominal).
CHS	Input	Chopper Stabilization. Connection for external stabilization components.
DA	Input	Ring-trip negative. Negative input to ring-trip comparator.
DB	Input	Ring-trip positive. Positive input to ring-trip comparator.
DET	Output	Detector. Logic Low indicates that the selected detector is tripped. Logic inputs C3–C1 and E1 select the detector. Open-collector with a built-in 15 k Ω pull-up resistor.
DGND	Gnd	(Am79514) Digital ground.
E0	Input	Read enable. A logic High enables DET. A logic Low disables DET.
E1	Input	E1 = High connects the ground-key detector to DET, and E1 = Low connects the off-hook or ring-trip detector to DET.
HPA	Capacitor	High-pass filter capacitor; A(TIP) side of high-pass filter capacitor.
HPB	Capacitor	High-pass filter capacitor; B(RING) side of high-pass filter capacitor.
L	Output	Switching Regulator Power Transistor. Connection point for filter inductor and anode of catch diode. Has up to 60 V pulse waveform; isolated from sensitive circuits. You must keep the diode connections short because of the high currents and high di/dt.
QBAT	Battery	Quiet battery. Filtered battery supply for the signal processing circuits. Connect external 100 Ω , 1/8 Ω resistor between QBAT and VBAT pins.
RD	Resistor	Detector resistor. Threshold modification/filter point for the off-hook detector.
RDC	Resistor	DC feed resistor. Connection point for the DC feed current programming network, which also connects to the receiver summing node (RSN). V _{RDC} is negative for normal polarity and positive for reverse polarity.
RINGOUT	Output	Ring relay driver; sourcing from BGND with internal diode to QBAT.
RSN	Input	The metallic current (AC and DC) between A(TIP) and B(RING) = 1000 x the current into this pin. The networks that program receive gain, two-wire impedance, and feed current all connect to this node. This node is extremely sensitive. Route the 256-kHz chopper clock and switch lines away from the RSN node.
TESTOUT	Output	Test relay driver. Sourcing from BGND with internal diode to QBAT.
TP	Thermal	Thermal pin. Connection for heat dissipation. Internally connected to substrate (QBAT). Leave as open circuit or connected to QBAT. In both cases, the TP pins can connect to an area of copper on the board to enhance heat dissipation
VBAT	Battery	Battery supply.
VCC	Power	+5 V power supply.
VEE	Power	−5 V power supply.
VREG	Input	Regulated voltage. Provides negative power supply for power amplifiers, connection point for inductor, filter capacitor, and chopper stabilization.
VTX	Output	Transmit Audio; Unity gain version of the A(TIP) and B(RING) metallic voltage. VTX also sources the two-wire input impedance programming network.

ABSOLUTE MAXIMUM RATINGS

Storage temperature55°C to +150°C
$\rm V_{CC}$ with respect to AGND/DGND –0.4 V to +7.0 V
$\rm V_{EE}$ with respect to AGND/DGND +0.4 V to –7.0 V
V_{BAT} with respect to AGND/DGND +0.4 V to -70 V
Note: Rise time of V_{BAT} (dv/dt) must be limited to 27 V/µs or less when Q_{BAT} bypass = 0.33 µF.
BGND with respect to AGND/DGND +1.0 V to -3.0 V A(TIP) or B(RING) to BGND:
Continuous70 V to +1.0 V
10 ms (f = 0.1 Hz) -70 V to +5.0 V
1 μs (f = 0.1 Hz) –90 V to +10 V
250 ns (f = 0.1 Hz)120 V to +15 V
Current from A(TIP) or B(RING)±150 mA
Voltage on RINGOUT BGND to 70 V above Q_{BAT}
Voltage on TESTOUT BGND to 70 V above $\mathbf{Q}_{\mathrm{BAT}}$
Current through relay drivers60 mA
Voltage on ring-trip inputs DA and DB $V_{BAT} to \; 0 \; V$
Current into ring-trip inputs±10 mA
Peak current into regulator switch (L pin) 150 mA
Switcher transient peak off voltage on L pin+1.0 V
C4–C1, E1, CHCLK, to AGND/DGND–0.4 V to V_{CC} + 0.4 V
Maximum power dissipation, (see note) $T_A = 70$ °C
In 28-pin ceramic DIP package2.58 W In 28-pin plastic DIP package1.4 W In 32-pin PLCC package1.74 W

Note: Thermal limiting circuitry on chip will shut down the circuit at a junction temperature of about 165°C. The device should never be exposed to this temperature. Operation above 145°C junction temperature may degrade device reliability. See the SLIC Packaging Considerations for more information.

Stresses above those listed under Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to Absolute Maximum Ratings for extended periods may affect device reliability.

OPERATING RANGES Commercial (C) Devices

Ambient temperature	0°C to +70°C*
V _{CC}	4.75 V to 5.25 V
V _{EE} 4	.75 V to -5.25 V
V _{BAT}	40 V to -63 V
AGND/DGND	0 V
BGND with respect to AGND/DGND100	mV to +100 mV
Load resistance on VTX to ground	10 kΩ min

Operating Ranges define those limits between which the functionality of the device is guaranteed.

^{*} Functionality of the device from 0°C to +70°C is guaranteed by production testing. Performance from -40°C to +85°C is guaranteed by characterization and periodic sampling of production units.

ELECTRICAL CHARACTERISTICS

Description	Test Conditions (See Note 1)	Min	Тур	Max	Unit	Note
Analog (V _{TX}) output impedance				3	20	W	
Analog (V _{TX}) output offset	0°C to +70°C -40°C to +85°C		-35 -40		+35 +40	mV	-
Analog (RSN) input impedance 300 Hz to 3.4 kHz				1	20		
Longitudinal impedance at A or B	pedance				35	W	
Overload level $Z_{2WIN} = 600 \Omega$ to 900Ω	4-wire 2-wire		-3.1 -3.1		+3.1 +3.1	Vpk	2
Transmission Performance, 2-	Wire Impedance	L.				•	
2-wire return loss 300 Hz to 500 Hz (See Test Circuit D) 500 Hz to 2500 Hz 2500 Hz to 3400 Hz		26 26 20			dB	4 — —	
Longitudinal Balance (2-Wire	and 4-Wire, See Test Circuit C)					_	
Longitudinal to metallic L-T, L-4	200 Hz to 1 kHz: normal polarity	-1*	50				
	0°C to +70°C normal polarity -40°C to+85°C	-2 -2 -2	63 58 58				5
	reverse polarity 1 kHz to 3.4 kHz:	-∠ -1*	52			1	5
	normal polarity 0°C to +70°C normal polarity -40°C to +85°C	-1 -2 -2	52 58 54			dB	
	reverse polarity	-2	54				
Longitudinal sum (L-T) + (T-L)	300 to 3400 Hz		95				
Longitudinal signal generation 4-L or T-L	300 to 800 Hz 800 to 3400 Hz		40 35				
Longitudinal current capability per wire	Active state OHT state				17 8	mArms	
Insertion Loss (2- to 4-Wire an	d 4- to 2-Wire, See Test Circuits A	and	В)				
Gain accuracy	0 dBm, 1 kHz, 0°C to +70°C 0 dBm, 1 kHz,		-0.15		+0.15		
	-40°C to +85°C 0 dBm, 1 kHz, 0°C to +70°C	-1*	-0.20 -0.1		+0.20 +0.1		4
	0 dBm, 1 kHz, -40°C to +85°C	-1	-0.15		+0.15	dB	4
Variation with frequency	300 Hz to 3400 Hz Relative to 1 kHz 0°C to +70°C -40°C to +85°C		-0.1 -0.15		+0.1 +0.15	45	4
Gain tracking	+7 dBm to -55 dBm 0°C to +70°C -40°C to +85°C		-0.1 -0.15		+0.1 +0.15	-	

Note:

^{*} P.G. = Performance Grade

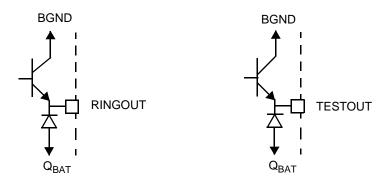
ELECTRICAL CHARACTERISTICS (CONTINUED)

Description	Test Conditions (See Note 1)	Min	Тур	Max	Unit	Note
Balance Return Signal (4-Wire	to 4-Wire, See Test Circuit B)			•		
Gain accuracy	0 dBm, 1 kHz, 0°C to +70°C 0 dBm, 1 kHz,	-0.15		+0.15		
	-40°C to +85°C 0 dBm, 1 kHz,	-0.20		+0.20		4
	0°C to +70°C —1 0 dBm, 1 kHz,	* - 0.1		+0.1		
	-40°C to +85°C -1	-0.15		+0.15	dB	4
Variation with frequency	300 Hz to 3400 Hz Relative to 1 kHz 0°C to +70°C -40°C to +85°C	-0.1 -0.15		+0.1 +0.15		
Gain tracking	+7 dBm to -55 dBm 0°C to +70°C -40°C to +85°C	0°C to +70°C		+0.1 +0.15		
Group delay	f = 1 kHz		5.3		μs	
Total Harmonic Distortion (2-	to 4-Wire or 4- to 2-Wire, See Test Circ	uits A and	B)	•	•	
Distortion level	0 dBm, 300 Hz to 3400 Hz		-64	-50	dB	
Distortion level	+9 dBm		-55	-40	uВ	
Idle Channel Noise						
Psophometric weighted noise	2-wire 0°C to +70°C 2-wire -40°C to +85°C		-83 -83	-78 -75	- dBmp	7 4, 7
	4-wire 0°C to +70°C 4-wire -40°C to +85°C		-83 -83	-78 -75	ч	7 4, 7
Single Frequency Out-of-Ban	d Noise (See Test Circuit E)	•	•	•	•	
Metallic	4 kHz to 9 kHz 9 kHz to 1 MHz 256 kHz and harmonics		-76 -76 -57		- dBm	4, 5, 9 4, 5
Longitudinal	1 kHz to 15 kHz Above 15 kHz 256 kHz and harmonics		-70 -85 -57		ubili	4, 5, 9 4, 5
DC Feed Current and Voltage Unless otherwise noted, Batto	(See Figure 1) ery = 60 V (V _{BAT} = -59.3 V)	•				
Active state loop-current accuracy	I_{LOOP} (nominal) = 40 mA R_L = 2000 Ω, Battery = 62 V -1 R_L = 2080 Ω -2			+7.5	% mA mA	4
On-hook loop voltage	R _L = ∞	47.5	49		V	
OHT state Tip Open state Disconnect state	$R_{L} = 600 \Omega$ $R_{L} = 600 \Omega$ $R_{L} = 0$	18	20	22 1.0 1.0	mA	
Power Dissipation, Battery = -	-60 V		•	•	•	
On-hook Open Circuit state On-hook OHT state On-hook Active state Off-hook OHT state Off-hook Active state	$R_L = 600 \Omega$ $R_I = 600 \Omega$		50 175 260 500 650	120 250 400 750 1000	mW	

ELECTRICAL CHARACTERISTICS (CONTINUED)

Description	Test Conditions (See Note 1)	Min	Тур	Max	Unit	Note
Supply Currents	•	<u>'</u>			•	
V _{CC} On-hook supply current	Open Circuit state OHT state Active state		3 6 7.5	4.5 10 12		
V _{EE} On-hook supply current	Open Circuit state OHT state Active state		1.0 2.2 2.7	2.3 3.5 6.0	mA	
V _{BAT} On-hook supply current	Open Circuit state OHT state Active state		0.4 3.0 4.0	1.0 5.0 6.0		
Power Supply Rejection Ratio	(V _{RIPPLE} = 50 mVrms)					
V _{CC}	40 Hz to 3400 Hz 3.4 kHz to 50 kHz	20 20	35 30			6, 7 —
V _{EE}	40 Hz to 3400 Hz 3.4 kHz to 50 kHz	20 15	30 25		dB	6, 7 —
V_{BAT}	40 Hz to 3400 Hz 3.4 kHz to 50 kHz	27 20	30 30			6, 7 —
Off-Hook Detector						
Current threshold	$I_{DET} = 365/R_D$	-20		+20	%	
Ground-Key Detector Thresh	olds Active State, Battery = −60 V					
Ground-key resistance threshol	d B(RING) to GND	2.0	4.2	10.0	kΩ	
Ground-key current threshold	B(RING) or midpoint to GND		9		mA	8
Ring-Trip Detector Input						
Bias current		-5	-0.05		μΑ	
Offset voltage	Source resistance = 0 to 200 k Ω	-50	0	+50	mV	
Logic Inputs (C4-C1, E1, and	CHCLK)					
Input High voltage		2.0			V	
Input Low voltage				0.8		
Input High current	All inputs except E1 Input E1	–75 –75		40 45	μΑ	
Input Low current		-0.4			mA	
Logic Output (DET)						
Output Low voltage	I _{OUT} = 0.8 mA			0.4		
Output High voltage	I _{OUT} = -0.1 mA	2.4			- V	
Relay Driver Outputs (RINGO	UT, TESTOUT)					
On voltage	50 mA source	B _{GND} –2			V	
Off leakage			0.5	100	μΑ	
Clamp voltage	50 mA sink	Q _{BAT} -2			V	

RELAY DRIVER SCHEMATICS

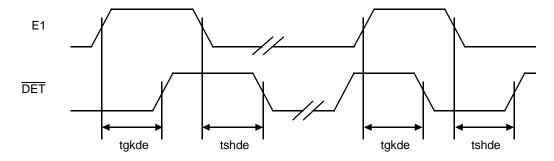


SWITCHING CHARACTERISTICS

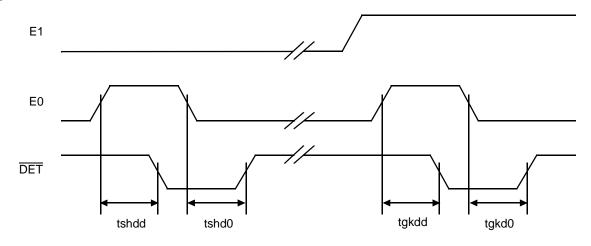
Symbol	Parameter	Test Conditions	Temperature Ranges	Min	Тур	Max	Unit	Note
tgkde	E1 Low to DET High (E0 = 1)		0°C to +70°C -40°C to +85°C			3.8 4.0		
	E1 Low to DET Low (E0 = 1)	Ground-key Detect state R _I open, R _G connected	0°C to +70°C -40°C to +85°C			1.1 1.6		
tgkdd	E0 High to $\overline{\text{DET}}$ Low (E1 = 0)	(See Figure H)	0°C to +70°C -40°C to +85°C			1.1 1.6		
tgkd0	E0 Low to DET High (E1 = 0)		0°C to +70°C -40°C to +85°C			3.8 4.0		4
tshde	E1 High to DET Low (E0 = 1)		0°C to +70°C -40°C to +85°C			1.2 1.7	μs	4
	E1 High to DET High (E0 = 1)	Switchhook Detect state $R_1 = 600 \Omega$, R_G open	0°C to +70°C -40°C to +85°C			3.8 4.0		
tshdd	E0 High to DET Low (E1 = 1)	(See Figure G)	0°C to +70°C -40°C to +85°C			1.1 1.6		
tshd0	E0 Low to DET High (E1 = 1)		0°C to +70°C -40°C to +85°C			3.8 4.0		

SWITCHING WAVEFORMS

E1 to DET



E0 to DET



Note:

All delays measured at 1.4 V level.

Notes:

- Unless otherwise noted, test conditions are BAT = -60 V, V_{CC} = +5 V, V_{EE} = -5 V, R_L = 600 Ω, C_{HP} = 0.33 μF, R_{DC1} = R_{DC2} = 31.25 kΩ, C_{DC} = 0.1 μF, Rd = 51.1 kΩ, no fuse resistors, two-wire AC output impedance programming impedance (Z_T) = 600 kΩ resistive, receive input summing impedance (Z_{RX}) = 300 kΩ resistive. (See Table 2 for component formulas.)
- 2. Overload level is defined when THD = 1%.
- 3. Balance return signal is the signal generated at V_{TX} by V_{RX} . This specification assumes that the two-wire AC load impedance matches the impedance programmed by Z_T .
- 4. Not tested in production. This parameter is guaranteed by characterization or correlation to other tests.
- 5. These tests are performed with a longitudinal impedance of 90Ω and metallic impedance of 300Ω for frequencies below 12 kHz and 135 Ω for frequencies greater than 12 kHz. These tests are extremely sensitive to circuit board layout. Please refer to application notes for details.
- 6. This parameter is tested at 1 kHz in production. Performance at other frequencies is guaranteed by characterization.
- 7. When the SLIC is in the Anti-Sat 2 operating region, this parameter is degraded. The exact degradation depends on system design. The Anti-Sat 2 region occurs at high loop resistances when $|V_{BAT}| |V_{AX} V_{BX}|$ is less than approximately 15 V.
- 8. "Midpoint" is defined as the connection point between two 300 Ω series resistors connected between A(TIP) and B(RING).
- 9. Fundamental and harmonics from 256 kHz switch regulator chopper are not included.

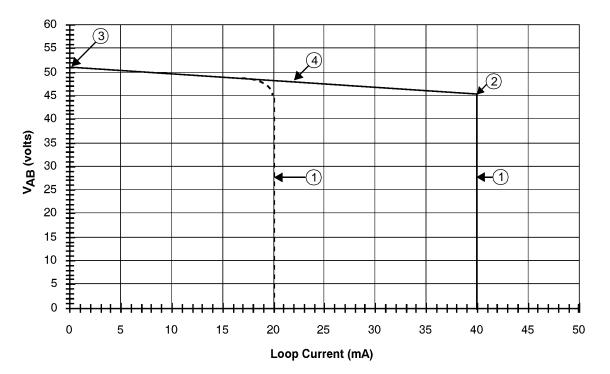
Table 1. SLIC Decoding

			DET Output	
State	C3 C2 C1	Two-Wire Status	E1 = 0	E1 = 1
0	0 0 0	Open Circuit	Ring trip	Ring trip
1	0 0 1	Ringing	Ring trip	Ring trip
2	0 1 0	Active	Loop detector	Ground key
3	0 1 1	On-hook TX (OHT)	Loop detector	Ground key
4	1 0 0	Tip Open	Loop detector	_
5	1 0 1	Reserved	Loop detector	_
6	1 1 0	Active Polarity Reversal	Loop detector	Ground key
7	1 1 1	OHT Polarity Reversal	Loop detector	Ground key

Table 2. User-Programmable Components

$Z_{\rm T} = 1000(Z_{\rm 2WIN} - 2R_{\rm F})$	Where Z_T is connected between the VTX and RSN pins. The fuse resistors are R_F , and Z_{2WIN} is the desired 2-wire AC input impedance. When computing Z_T , the internal current amplifier pole and any external stray capacitance between VTX and RSN must be taken into account.
$Z_{RX} = \frac{Z_{L}}{G_{42L}} \bullet \frac{1000 \bullet Z_{T}}{Z_{T} + 1000(Z_{L} + 2R_{F})}$	Where Z_{RX} is connected from V_{RX} to the RSN pin, Z_T is defined above, G_{42L} is the desired receive gain, and Z_L is the 2-wire load impedance.
$R_{DC1} + R_{DC2} = \frac{2500}{I_{FEED}}$	Where R_{DC1} , R_{DC2} , and C_{DC} form the network $C_{DC} = (1.5 \text{ ms})(R_{DC1} + R_{DC2})/(R_{DC1} \bullet R_{DC2})$ connected to the RDC pin. R_{DC1} and R_{DC2} are approximately equal.
$R_{\rm D} = \frac{365}{I_{\rm T}}, \qquad C_{\rm D} = \frac{0.5 \text{ ms}}{R_{\rm D}}$	Where R_D and C_D form the network connected from RD to $-5~\rm V$ and I_T is the threshold current between on hook and off hook.

DC FEED CHARACTERISTICS



$$V_{BAT} = 62.3 \text{ V}$$

 $R_{DC} = 62.5 \text{ k}\Omega$

Notes:

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1. Constant-current region:

Active state,
$$I_L = \frac{2500}{R_{DC}}$$

OHT state, $I_L \,=\, \frac{1}{2} \bullet \frac{2500}{R_{DC}}$

2. Anti-sat cut-in:
$$V_{AB} = 46 \text{ V}, \qquad |V_{BAT}| \ge 58.9 \text{ V}$$

$$V_{AB} = 1.087 |V_{BAT}| - 18.017, |V_{BAT}| < 58.9 \text{ V}$$

3. Open Circuit voltage:
$$V_{AB} = 51.23 \text{ V}, \qquad |V_{BAT}| \ge 61.5 \text{ V}$$

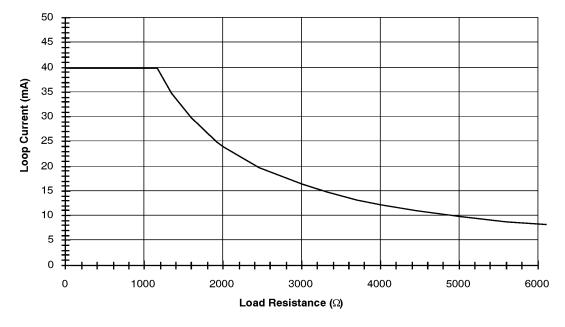
$$V_{AB} = 1.073 |V_{BAT}| - 14.72, |V_{BAT}| < 61.5 V$$

4. Anti-sat 1 region:
$$V_{AB} = 51.23 - I_L \frac{R_{DC}}{488.3}$$

5. Anti-sat 2 region:
$$V_{AB} = 1.073 |V_{BAT}| - 14.72 - I_L \frac{R_{DC}}{1071}$$

a. V_A-V_B (V_{AB}) Voltage vs. Loop Current (Typical)

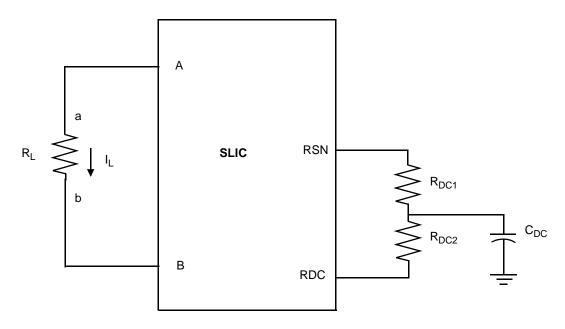
DC FEED CHARACTERISTICS (continued)



 $V_{BAT} = 62.3 \text{ V}$

 $R_{DC} = 62.5 \text{ k}\Omega$

b. Loop Current vs. Load Resistance (Typical)

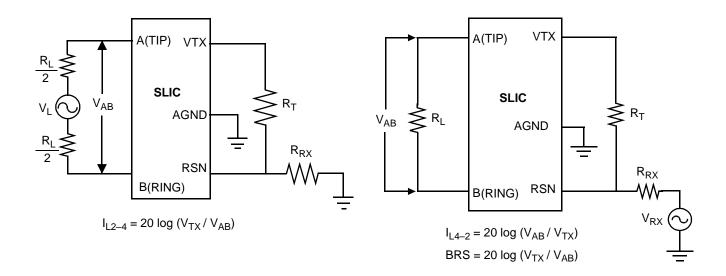


Feed current programmed by $\mathrm{R}_{\mathrm{DC1}}$ and $\mathrm{R}_{\mathrm{DC2}}$

c. Feed Programming

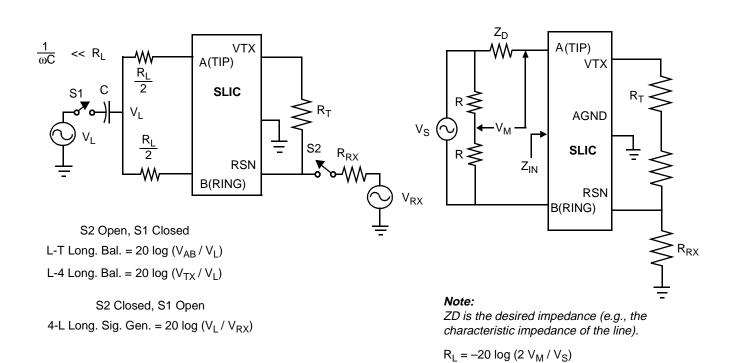
Figure 1. DC Feed Characteristics

TEST CIRCUITS



A. Two- to Four-Wire Insertion Loss

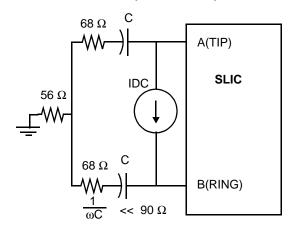
B. Four- to Two-Wire Insertion Loss and Balance Return Signal



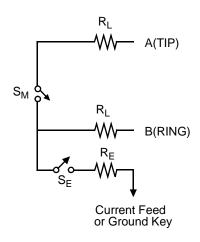
C. Longitudinal Balance

D. Two-Wire Return Loss Test Circuit

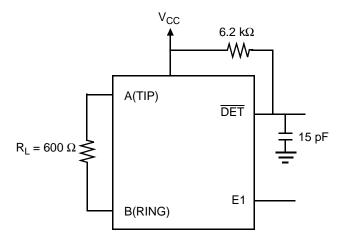
TEST CIRCUITS (continued)



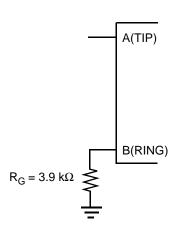
E. Single-Frequency Noise



F. Ground-Key Detection



G. Loop-Detector Switching



H. Ground-Key Switching

REVISION SUMMARY

Revision A to Revision B

Minor changes were made to the data sheet style and format to conform to AMD standards.

Revision B to Revision C

- In Pin Description table, inserted/changed TP pin description to: "Thermal pin. Connection for heat dissipation. Internally connected to substrate (QBAT). Leave as open circuit or connected to QBAT. In both cases, the TP pins can connect to an area of copper on the board to enhance heat dissipation."
- Minor changes were made to the data sheet style and format to conform to AMD standards.

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